Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination SCHROER ET AL.	
10/612,601		
Examiner	Art Unit	
Karin M. Reichle	3761	

SEARCHED				
Class	Subclass	Date	Examiner	
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TAI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH (INCLUDING SEAR)
	DATE	EXMR
Appeal conference held	6/22/2006	KMR